



**N-Ch MOSFET** 

#### **General Description**

The WSD100N06GDN56 is the SGT MOSFET with extreme high cell density, which provide excellent R<sub>DSON</sub> and gate charge for most of the synchronous buck converter applications.

The WSD100N06GDN56 meet the RoHS and Green Product requirement 100% EAS guaranteed with full function reliability approved.

#### **Features**

Lead Fre e an d Green Devices Available

(RoH SCom plia nt)

100% UIS + Rg Tested

Reliable and Rugged

Moistu re Sensitivity Level MSL1

(per JED EC J-STD-020D)

## **Product Summery**

Bvdss	Rdson	ΙD
60V	$3.0$ m $\Omega$	100A

#### **Applications**

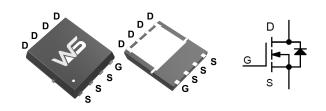
Secondary Side Synchronous Rectification

DC-DC Converter

Motor Control

Load Switching

## DFN5x6A-8\_EP Pin Configuration



### Absolute Maximum Ratings @Ta=25°C unless otherwise noted

Symbol	Parameter	Rating	Units		
V <sub>DS</sub>	Drain-Source Voltage	60	V		
V <sub>GS</sub>	Gate-Source Voltage	±20	V		
$I_{\mathrm{D}}^{1,6}$	Continuous Drain Current	=25°C	100		
		e=100°C	65	A	
I <sub>DM</sub> <sup>2</sup>	Pulsed Drain Current To	=25°C	240	A	
PD	Maximum Power Dissipation	=25°C	83	W	
		c=100°C	50		
$I_{AS}$	Avalanche Current, Single pulse	45	A		
Eas <sup>3</sup>	Single Pulse Avalanche Energy	101	mJ		
TJ	Maximum Junction Temperature	150	$^{\circ}$ C		
Tstg	Storage Temperature Range	-55 to 150	$^{\circ}$		
$R_{\theta JA}{}^1$	Thermal Resistance Junction to ambient	Steady State	State 55		
ReJc¹	Thermal Resistance-Junction to Case	Steady State	1.5	°C/W	



**N-Ch MOSFET** 

### Electrical Characteristics @TA=25°C unless otherwise noted

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Static	•					
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250 \mu A$	60			V
Idss	Zero Gate Voltage Drain Current	$V_{DS}=48 \text{ V}, V_{GS}=0 \text{V}$			1	μА
IDSS		T <sub>J</sub> =85°C			30	
Igss	Gate Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA
On Characte	ristics					
V <sub>GS(TH)</sub>	Gate Threshold Voltage	$V_{GS}=V_{DS},I_{DS}=250\mu A$	1.2	1.8	2.5	V
D 2	D : C O AA D :A	$V_{GS} = 10V, I_D = 20A$		3.0	3.6	mΩ
R <sub>DS(on)</sub> <sup>2</sup>	Drain-Source On-state Resistance	$V_{GS} = 4.5V$ , $I_D = 15A$		4.4	5.4	mΩ
Switching						
Qg	Total Gate Charge	$V_{DS}=30V$		58		nC
Qgs	Gate-Sour Charge	$V_{GS}=10V$		16		nC
Qgd	Gate-Drain Charge	I <sub>D</sub> =20A		4.0		пC
td (on)	Turn-on Delay Time	V <sub>GEN</sub> =10V		18		ns
tr	Turn-on Rise Time	V <sub>DD</sub> =30V I <sub>D</sub> =20A		8		ns
td(off)	Turn-off Delay Time	R <sub>G</sub> =Ω		50		ns
tf	Turn-off Fall Time			11		ns
Rg	Gat resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz		0.7		Ω
Dynamic						
Ciss	In Capacitance	$ m V_{GS}\!\!=\!\!0V$		3458		pF
Coss	Out Capacitance	$V_{DS}=30V$		1522		pF
Crss	Reverse Transfer Capacitance	f=1MHz		22		pF
Drain-Source	e Diode Characteristics and Maximum	Ratings				
Is <sup>1,5</sup>	Continuous Source Current	W-W-OW E			55	A
Іѕм	Pulsed Source Current3	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			240	A
$V_{ m SD}^{\ 2}$	Diode Forward Voltage	$I_{SD} = 1A$ , $V_{GS}=0V$		0.8	1.3	V
<b>t</b> rr	Reverse Recovery Time	I <sub>SD</sub> =20A, dl <sub>SD</sub> /dt=100A/μs		27		ns
Qrr	Reverse Recovery Charge	1SD 2011, αιςD αι 10011/μ5		33		пC

#### Note

- 1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%
- 3. The EAS data shows Max. rating . The test condition is  $V_{DD}$ =50V,  $V_{GS}$ =10V, L=0.1mH,  $I_{AS}$ =40A
- 4.The power dissipation is limited by 150°C junction temperature
- 5. The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.
- 6. The maximum current rating is package limited.



# **Typical Operating Characteristics**

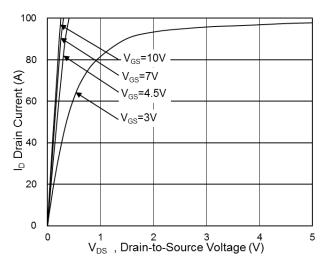


Fig.1 Typical Output Characteristics

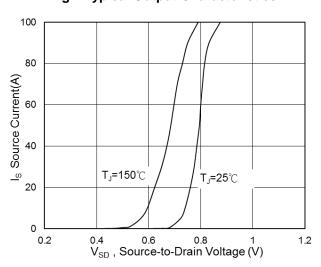


Fig.3 Diode Forward Voltage vs. Current

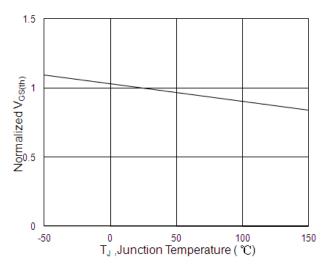


Fig.5 Normalized V<sub>GS(th)</sub> vs T<sub>J</sub>

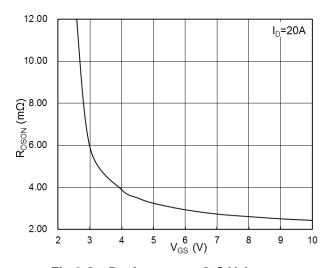


Fig.2 On-Resistance vs G-S Voltage

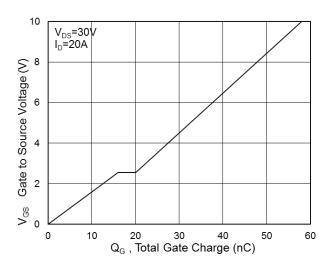


Fig.4 Gate-Charge Characteristics

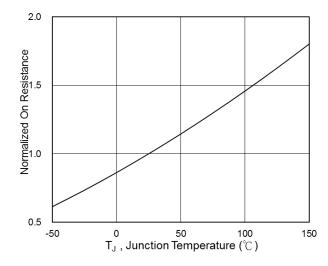
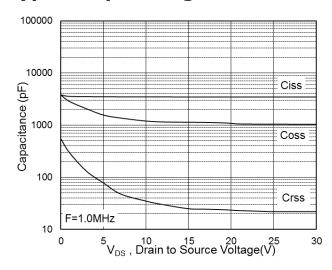


Fig.6 Normalized R<sub>DSON</sub> vs T<sub>J</sub>



# **Typical Operating Characteristics (Cont.)**



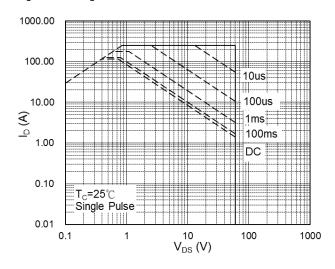


Fig.7 Capacitance

Fig.8 Safe Operating Area

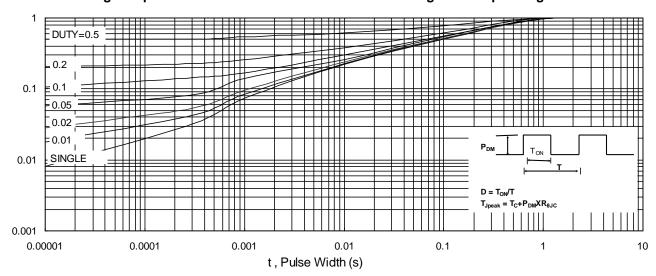


Fig.9 Normalized Maximum Transient Thermal Impedance

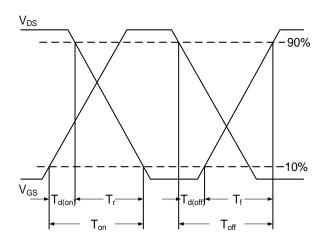


Fig.10 Switching Time Waveform

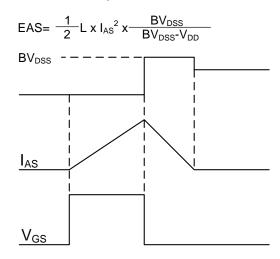


Fig.11 Unclamped Inductive Switching Waveform



#### **Attention**

- 1, Any and all Winsok power products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life-support systems, aircraft's control systems, or other applications whose failure can be reasonably expected to result in serious physical and/or material damage. Consult with your Winsok power representative nearest you before using any Winsok power products described or contained herein in such applications.
- 2, Winsok power assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all Winsok power products described or contained herein.
- 3, Specifications of any and all Winsok power products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer's products or equipment.
- 4, Winsok power Semiconductor CO., LTD. strives to supply high-quality high-reliability products. However, any and all semiconductor products fail with some probability. It is possible that these probabilistic failures could give rise to accidents or events that could endanger human lives that could give rise to smoke or fire, or that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents or events cannot occur. Such measures include but are not limited to protective circuits and error prevention circuits for safe design, redundant design, and structural design.
- 5,In the event that any or all Winsok power products (including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported without obtaining the export license from the authorities concerned in accordance with the above law.
- 6, No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written permission of Winsok power Semiconductor CO., LTD.
- 7, Information (including circuit diagrams and circuit parameters) herein is for example only; it is not guaranteed for volume production. Winsok power believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringements of intellectual property rights or other rights of third parties.
- 8, Any and all information described or contained herein are subject to change without notice due to product/technology improvement, etc. When designing equipment, refer to the "Delivery Specification" for the Winsok power product that you Intend to use.
- 9, this catalog provides information as of Sep.2014. Specifications and information herein are subject to change without notice.